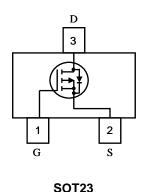


P-Channel Enhancement Mode Field Effect Transistor

Features General Description VDS (V) = -15 V This P-Channel enhancement mode power FETs are produced with high cell density, DMOS trench technology, which is $R_{DS(ON)} = 28m \Omega$ @VGS = -4.5V RDS(ON) = 37m Ω @VGS = -2.5V especially used to minimize on-state resistance. This device is particularly suited for low voltage application such as portable equipment, power management and other battery powered circuits, and low in-line power loss are needed in a very small outline surface mount package.

Pin Configurations



Absolute Maximum Ratings @T_A=25℃ unless otherwise noted

Parameter		Symbol	Ratings	Unit	
Drain-Source Voltage		Voss	-15	V	
Gate-Source Voltage		Vgss	± 8	V	
Drain Current	Continuous	l-	-6.0	^	
	Pulsed ₍₁₎	lo lo	-20	А	
Power Dissipation		Po	350	mW	
Operating and Storage Temperature Range		ТЈ,Тѕтс	-55 to 150	$^{\circ}$	

● Electrical Characteristics @T_A=25°C unless otherwise noted

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit	
OFF CHARACTERISTICS	•	1		l.	l		
Drain-Source Breakdown Voltage	V _{(BR)DSS}	Vgs = 0 V, Ib = -250 μA	-15			V	
Zero Gate Voltage Drain Current	Ipss	V _{DS} = -15V, V _{GS} = 0 V			-1	μΑ	
Gate - Body Leakage, Forward	Igssf	Vgs = +8 V, Vps = 0 V			100	nA	
Gate - Body Leakage, Reverse	Igssr	Vgs = -8 V, Vps = 0 V			-100	nA	
ON CHARACTERISTICS (2)							
Gate Threshold Voltage	VGS (TH)	V _{DS} = V _{GS} , I _D = -250 μA	-0.5	-0.7	-0.9	V	
		Vgs = -4.5 V, ID = -6.0 A		28	36	mΩ	
Static Drain-Source On-Resistance	RDS(ON)	Vgs = -2.5 V, ID = -4.5 A		37	44		
		Vgs = -1.8 V, ID = -2.0 A		50	71		
Forward Transconductance	GFS	V _{DS} = -5 V, I _D = -2.8 A	4	6		S	
DYNAMIC CHARACTERISTICS (3)				•			
Input Capacitance	Ciss	V 0VV 0V 5 40		650		pF	
Output Capacitance	Coss	V _{DS} = -6 V, V _{GS} = 0 V, F = 1.0 MHz		72		pF	
Reverse Transfer Capacitance	Crss	IVITZ		58		pF	
SWITCHING CHARACTERISTICS (3)							
Turn-On Delay Time	T _{D(ON)}	$V_{DD} = -6 \text{ V}, R_L = 6\Omega, I_D = -1.0 \text{ A},$			20	ns	
Turn-On Rise Time	TR	$V_{GEN} = -4.5 \text{ V,Rg} = 6 \Omega$			10		
Turn-Off Delay Time	T _{D(OFF)}	V_{DD} = -6 V, R_L = 6 Ω , I_D = -1.0 A,			65	ns	
Turn-Off Fall Time	TF	$V_{GEN} = -4.5 \text{ V,Rg} = 6 \Omega$			45		
DRAIN-SOURCE DIODE CHARACTERIS	STICS AND N	MAXIMUM RATINGS					
Drain-Source Diode Forward Current ₍₄₎	Is				-1.35	Α	
Drain-Source Diode Forward Voltage(2)	Vsp	Vgs = 0 V, Is = -0.75 A	-0.6	-0.8	-1.3	V	

Notes

- 1. Pulse width limited by maximum junction temperature.
- 2、Pulse test: PW≤300 µ s, duty cycle≤2%.
- 3. Guaranteed by design, not subject to production testing.
- 4. Surface Mounted on FR4 Board,T < 5 sec.

Typical Performance Characteristics (TJ =25 Noted)

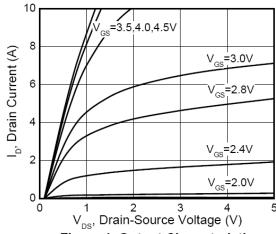
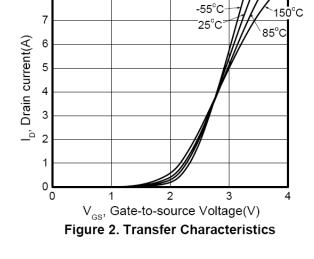
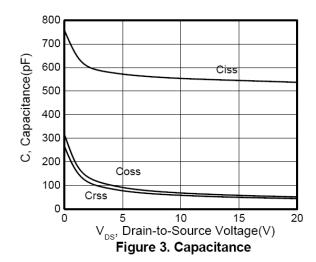


Figure 1. Output Characteristics





V_{TH}, Gate-Source Threshold Voltage (V) 1.3 1.2 1.1 1.0

1.6

1.5

1.4

0.9 **L** -50 0 50 100 Tj, Junction Temperature (°C) Figure 5. Gate Thershold Vs. Temperature

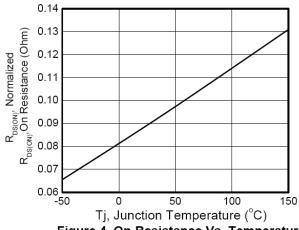
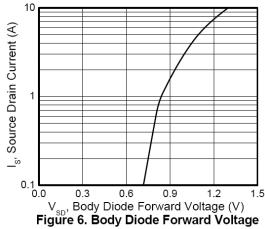


Figure 4. On Resistance Vs. Temperature



Vs. Source Current